RoHS Compliant
HALOGEN-FREE

MDP11N60

N-Channel MOSFET 600V, 11A, 0.55Ω

General Description

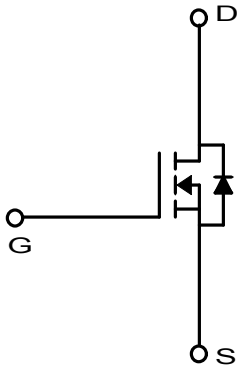
MDP11N60 is suitable device for SMPS, high Speed switching and general purpose applications.

Features

- V_{DS} = 600V
- I_D = 11A @ V_{GS} = 10V
- $R_{DS(ON)}$ ≤ 0.55Ω @ V_{GS} = 10V

Applications

- Power Supply
- PFC
- High Current, High Speed Switching



Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage		V_{GSS}	±30	V
Continuous Drain Current (※)	T_C=25°C	I_D	11	A
	T_C=100°C		6.9	A
Pulsed Drain Current[1]		I_{DM}	44	A
Power Dissipation	T_C=25°C	P_D	182	W
	Derate above 25 °C		1.45	W/ °C
Peak Diode Recovery dv/dt[3]		Dv/dt	4.5	V/ns
Single Pulse Avalanche Energy[4]		E_{AS}	720	mJ
Junction and Storage Temperature Range		T_J, T_{stg}	-55~150	°C

※ Id limited by maximum junction temperature

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient[1]	$R_{\theta JA}$	62.5	°C/W
Thermal Resistance, Junction-to-Case[1]	$R_{\theta JC}$	0.69	

Ordering Information

Part Number	Temp. Range	Package	Packing	RoHS Status
MDP11N60	-55~150°C	TO-220	Tube	Halogen Free

Electrical Characteristics (Ta =25°C)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	I_D = 250μA, V_{GS} = 0V	600	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	3.0	-	5.0	
Drain Cut-Off Current	I_{DSS}	V_{DS} = 600V, V_{GS} = 0V	-	-	1	μA
Gate Leakage Current	I_{GSS}	V_{GS} = ±30V, V_{DS} = 0V	-	-	100	nA
Drain-Source ON Resistance	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 5.5A		0.45	0.55	Ω
Forward Transconductance	g_{fs}	V_{DS} = 30V, I_D = 5.5A	-	13	-	S
Dynamic Characteristics						
Total Gate Charge	Q_g	V_{DS} = 480V, I_D = 11A, V_{GS} = 10V(3)	-	38.4	-	nC
Gate-Source Charge	Q_{gs}		-	11.2	-	
Gate-Drain Charge	Q_{gd}		-	14	-	
Input Capacitance	C_{iss}	V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz	-	1700		pF
Reverse Transfer Capacitance	C_{rss}		-	6.2		
Output Capacitance	C_{oss}		-	184		
Turn-On Delay Time	$t_{d(on)}$	V_{GS} = 10V, V_{DS} = 300V, I_D = 11A, R_G = 25Ω(3)	-	38		ns
Rise Time	t_r		-	50		
Turn-Off Delay Time	$t_{d(off)}$		-	76		
Fall Time	t_f		-	33		
Drain-Source Body Diode Characteristics						
Maximum Continuous Drain to Source Diode Forward Current	I_S		-	11	-	A
Source-Drain Diode Forward Voltage	V_{SD}	I_S = 11A, V_{GS} = 0V	-		1.4	V
Body Diode Reverse Recovery Time	t_{rr}	I_F = 11A, dI/dt = 100A/μs(3)	-	430		ns
Body Diode Reverse Recovery Charge	Q_{rr}		-	4.0		μC

Note :

1. Pulse width is based on $R_{\theta JC}$ & $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C.
2. Pulse test: pulse width ≤300us, duty cycle≤2%, pulse width limited by junction temperature $T_{J(MAX)}$=150°C.
3. I_{SD} ≤11.0A, di/dt≤200A/us, V_{DD}=50V, R_g =25Ω, Starting T_J=25°C
4. L=10.9mH, I_{AS}=11A, V_{DD}=50V, R_g =25Ω, Starting T_J=25°C

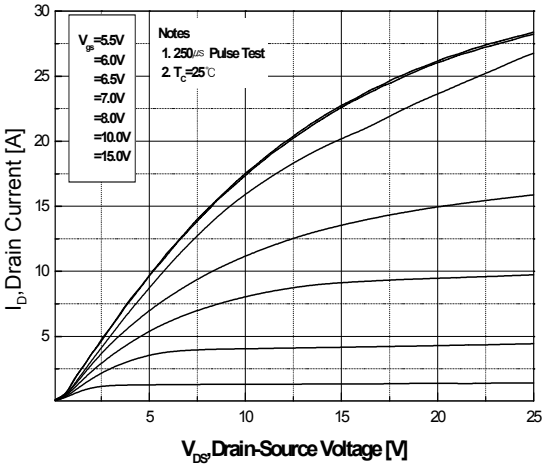


Fig.1 On-Region Characteristics

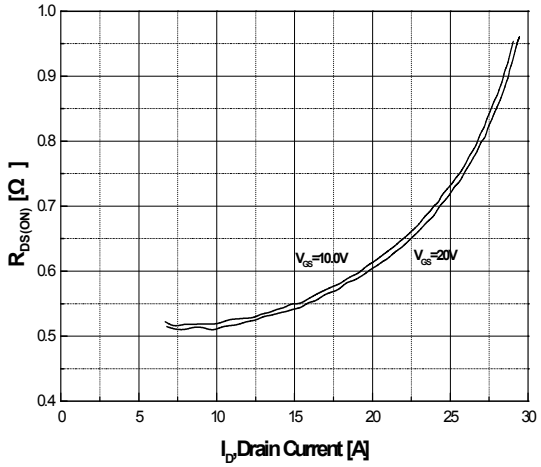


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

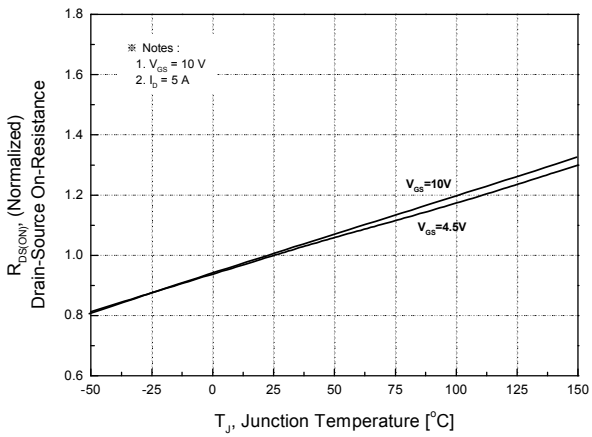


Fig.3 On-Resistance Variation with Temperature

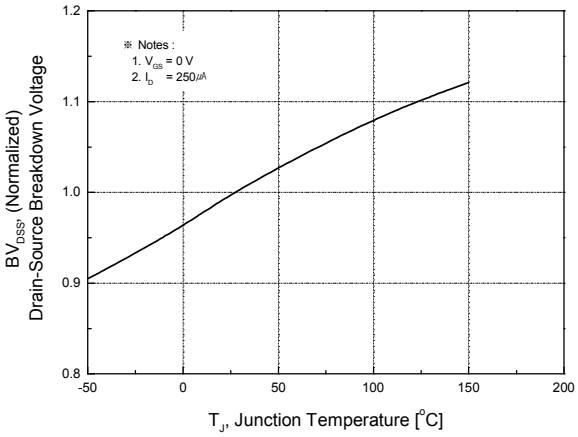


Fig.4 Breakdown Voltage Variation vs. Temperature

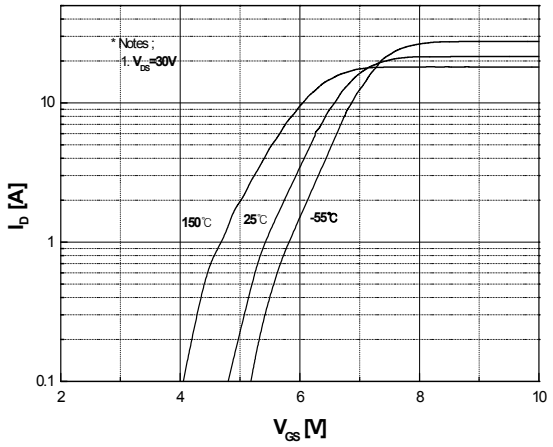


Fig.5 Transfer Characteristics

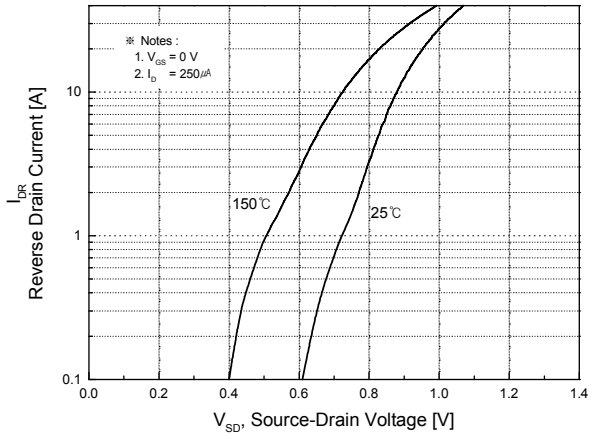


Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature

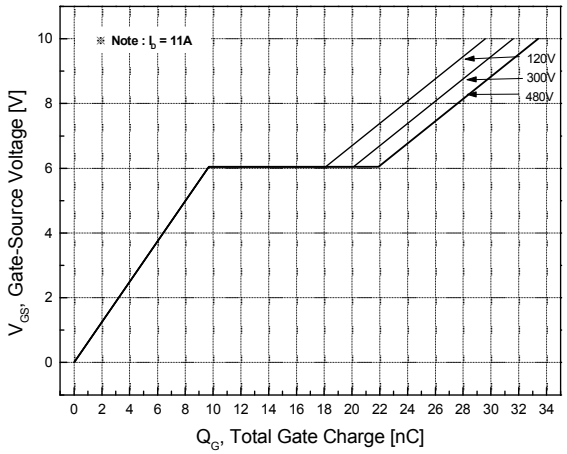


Fig.7 Gate Charge Characteristics

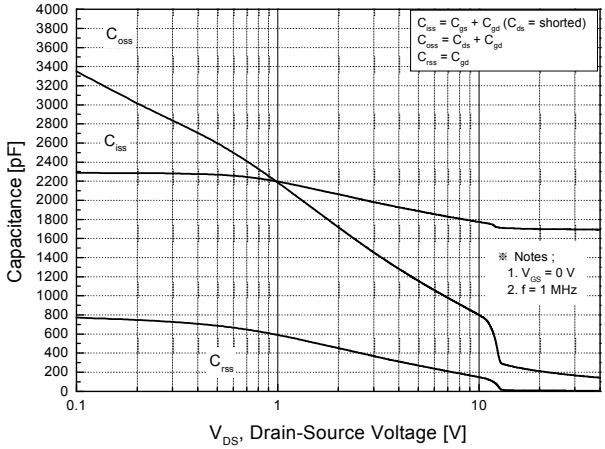


Fig.8 Capacitance Characteristics

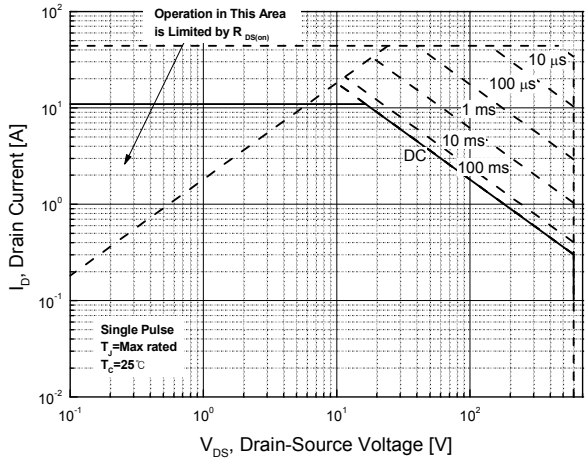


Fig.9 Maximum Safe Operating Area

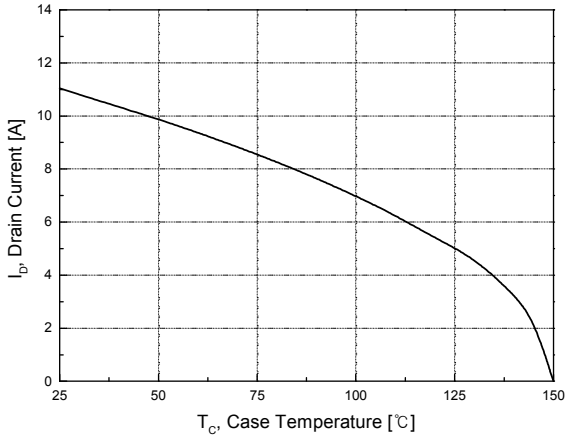


Fig.10 Maximum Drain Current vs. Case Temperature

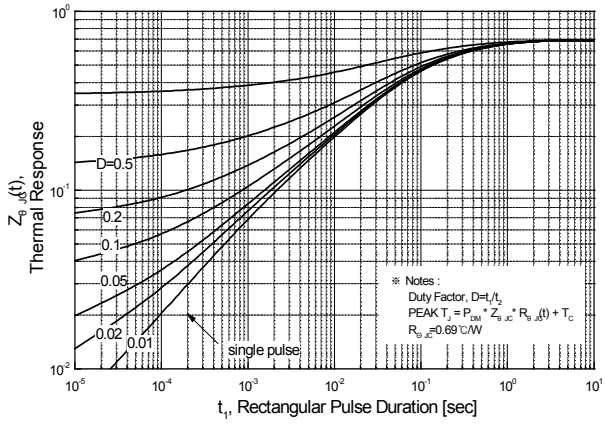


Fig.11 Transient Thermal Response Curve

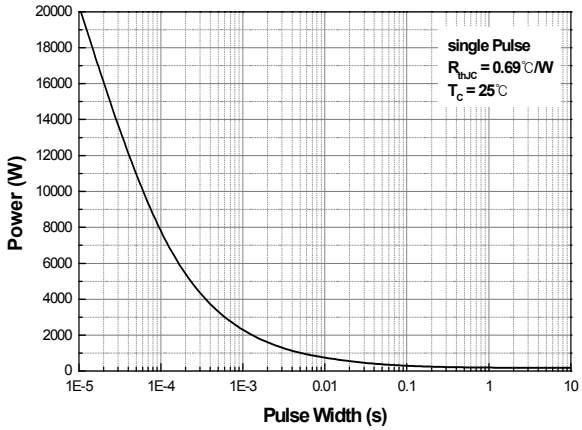


Fig.12 Single Pulse Maximum Power Dissipation

Physical Dimensions

TO-220